
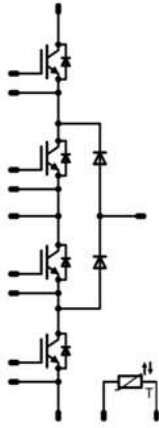




Vincotech

<i>flowNPC 0</i>	650 V / 60 A
<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;">Features</div> <ul style="list-style-type: none"> High Efficiency three-level half-bridge High efficiency IGBT Neutral point-Clamped inverter Clip-In PCB mounting Low Inductance Layout 	<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;">flow 0 12mm housing</div> 
<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;">Target applications</div> <ul style="list-style-type: none"> Solar UPS 	<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;">Schematic</div> 
<div style="background-color: #eee; padding: 2px; margin-bottom: 5px;">Types</div> <ul style="list-style-type: none"> 10-FZ07NIA060SM-P926F43 	

Maximum Ratings

$T_j=25^{\circ}\text{C}$, unless otherwise specified

Parameter	Symbol	Condition		Value	Unit
Buck Switch\ Out. Boost Switch					
Collector-emitter voltage	V_{CES}			650	V
Collector current	I_C	$T_j = T_{jmax}$	$T_s = 80^{\circ}\text{C}$	53	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}		180	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	$T_s = 80^{\circ}\text{C}$	97	W
Gate-emitter voltage	V_{GES}			± 20	V
Maximum Junction Temperature	T_{jmax}			175	$^{\circ}\text{C}$



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Parameter	Symbol	Conditions	Value	Unit
Buck Diode \ Out. Boost Diode				
Peak Repetitive Reverse Voltage	V_{RRM}		650	V
Continuous (direct) forward current	I_F	$T_j=T_{jmax}$ $T_h=80^{\circ}C$	45	A
Surge (non-repetitive) forward current	I_{FSM}	50Hz Single Half Sine Wave	500	A
Total power dissipation	P_{tot}	$T_j=T_{jmax}$ $T_h=80^{\circ}C$	76	W
Maximum Junction Temperature	T_{jmax}		175	$^{\circ}C$

Parameter	Symbol	Conditions	Value	Unit
Out. Boost Inv. Diode				
Peak Repetitive Reverse Voltage	V_{RRM}		650	V
Continuous (direct) forward current	I_F	$T_j=T_{jmax}$ $T_h=80^{\circ}C$	65	A
Repetitive peak forward current	I_{FRM}		150	A
Total power dissipation	P_{tot}	$T_j=T_{jmax}$ $T_h=80^{\circ}C$	85	W
Maximum Junction Temperature	T_{jmax}		175	$^{\circ}C$

Module Properties

Parameter	Symbol	Conditions	Value	Unit
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Thermal Properties

Storage temperature	T_{stg}		-40...+125	$^{\circ}C$
Operation Junction Temperature	T_{jop}		-40...+($T_{jmax} - 25$)	$^{\circ}C$

Isolation Properties

Isolation voltage	V_{isol}	DC voltage	$t_p=2s$	4000	V
Creepage distance				min 12,7	mm
Clearance				min 9,75	mm
Comparative Tracking Index	CTI			>200	



Vincotech

Characteristic Values

Buck Switch

Parameter	Symbol	Conditions					Value			Unit
		V_{GE} [V]	V_{CE} [V]	I_C [A]	T_j [°C]	Min	Typ	Max		

Static

Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{CE}=V_{CE}$			0,0006	25 125	3,3	4	4,7	V
Collector-emitter saturation voltage	V_{CEsat}		15		60	25 125 150		1,67 1,80 1,84	2,22	V
Collector-emitter cut-off current	I_{CES}		0	650		25 125			40	μA
Gate-emitter leakage current	I_{GES}		20	0		25 125			120	nA
Internal gate resistance	r_g							none		Ω
Input capacitance	C_{ies}	f=1 MHz	0	25		25		2100		pF
Reverse transfer capacitance	C_{res}							7,7		

Thermal

Thermal resistance junction to sink	$R_{th(j-s)}$	Phase-Change Material $\lambda=3,4W/mK$						0,98		K/W
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IGBT Switching

Turn-on delay time	$t_{d(on)}$	$R_{goff} = 16 \Omega$ $R_{gon} = 16 \Omega$	±15	350	60	25		115		ns
Rise time	t_r					125		117		
						150		117		
						25		18		
Turn-off delay time	$t_{d(off)}$					125		19		
		150		20						
		25		95						
Fall time	t_f	125		108						
		150		111						
		25		5						
Turn-on energy (per pulse)	E_{on}	$Q_{rFWD} = 0,7 \mu C$ $Q_{rFWD} = 2,1 \mu C$ $Q_{rFWD} = 2,5 \mu C$				25		1,128		mWs
						125		1,485		
						150		1,571		
Turn-off energy (per pulse)	E_{off}					25		0,220		
						125		0,415		
		150		0,465						



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Buck Diode

Parameter	Symbol	Conditions					Value			Unit
		v_r [V]	I_F [A]	T_j [°C]	Min	Typ	Max			

Static

Forward voltage	V_F				50	25 125 150		2,30 1,94 1,86	2,6	V
Reverse leakage current	I_r			665		25 150			10 -	μ A

Thermal

Thermal resistance junction to sink	$R_{th(j-s)}$	Phase-Change Material $\lambda=3,4\text{W/mK}$						1,25		K/W
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FWD Switching

Peak recovery current	I_{RRM}	$di/dt = 2943\text{ A}/\mu\text{s}$ $di/dt = 2875\text{ A}/\mu\text{s}$ $di/dt = 2730\text{ A}/\mu\text{s}$	± 15	350	60	25		23		A
						125		32		
						150		36		
Reverse recovery time	t_{rr}					25		30		
						125		124		
		150		140						
Recovered charge	Q_r					25		0,692		μ C
						125		2,065		
						150		2,511		
Reverse recovered energy	E_{rec}					25		0,097		mWs
						125		0,340		
						150		0,422		
Peak rate of fall of recovery current	$(di_{rr}/dt)_{max}$					25		2675		A/ μ s
						125		480		
						150		691		



Vincotech

Out. Boost Switch

Parameter	Symbol	Conditions					Value			Unit
		V_{GE} [V]	V_{CE} [V]	I_C [A]	T_j [°C]	Min	Typ	Max		

Static

Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{GE}=V_{CE}$			0,0006	25 125	3,3	4	4,7	V
Collector-emitter saturation voltage	V_{CEsat}		15		60	25 125 150		1,67 1,80 1,84	2,22	V
Collector-emitter cut-off current	I_{CES}		0	650		25 125			40	μA
Gate-emitter leakage current	I_{GES}		20	0		25 125			120	nA
Internal gate resistance	r_g							none		Ω
Input capacitance	C_{ies}	f=1 MHz	0	25		25		2100		pF
Reverse transfer capacitance	C_{res}							7,7		

Thermal

Thermal resistance junction to sink	$R_{th(j-s)}$	Phase-Change Material $\lambda=3,4W/mK$						0,98		K/W
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IGBT Switching

Turn-on delay time	$t_{d(on)}$	$R_{goff} = 16 \Omega$ $R_{gon} = 16 \Omega$	± 15	350	60	25 125 150		119 118 119		ns
Rise time	t_r					25 125 150		17 20 21		
Turn-off delay time	$t_{d(off)}$					25 125 150		99 112 115		
Fall time	t_f					25 125 150		5 11 14		
Turn-on energy (per pulse)	E_{on}					$Q_{fFWD} = 0,7 \mu C$ $Q_{fFWD} = 2,1 \mu C$ $Q_{fFWD} = 2,6 \mu C$		25 125 150		
Turn-off energy (per pulse)	E_{off}			25 125 150		0,271 0,490 0,549		mWs		



Vincotech

Out. Boost Diode

Parameter	Symbol	Conditions					Value			Unit
				V_r [V]	I_F [A]	T_j [°C]	Min	Typ	Max	

Static

Forward voltage	V_F				50	25 125 150		2,30 1,94 1,86	2,6	V
Reverse leakage current	I_r			665		25 150			10 -	μ A

Thermal

Thermal resistance junction to sink	$R_{th(j-s)}$	Phase-Change Material $\lambda=3,4W/mK$						1,25		K/W
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FWD Switching

Peak recovery current	I_{RRM}					25 125 150		24 34 37		A
Reverse recovery time	t_{rr}					25 125 150		87 119 130		ns
Recovered charge	Q_r	$di/dt = 3120 A/\mu s$ $di/dt = 2136 A/\mu s$ $di/dt = 2000 A/\mu s$	± 15	350	60	25 125 150		0,701 2,072 2,592		μ C
Reverse recovered energy	E_{rec}					25 125 150		0,107 0,371 0,488		mWs
Peak rate of fall of recovery current	$(di_{rr}/dt)_{max}$					25 125 150		2742 398 488		A/ μ s



Vincotech

Out. Boost Inv. Diode

Parameter	Symbol	Conditions					Value			Unit
		V_r [V]	I_F [A]	T_j [°C]	Min	Typ	Max			

Static

Forward voltage	V_F			75	25 125 150		1,46 1,42 1,40	1,9	V
Reverse leakage current	I_r		650		25 150			27 -	μ A

Thermal

Thermal resistance junction to sink	$R_{th(j-s)}$	Phase-Change Material $\lambda=3,4W/mK$					1,12		K/W
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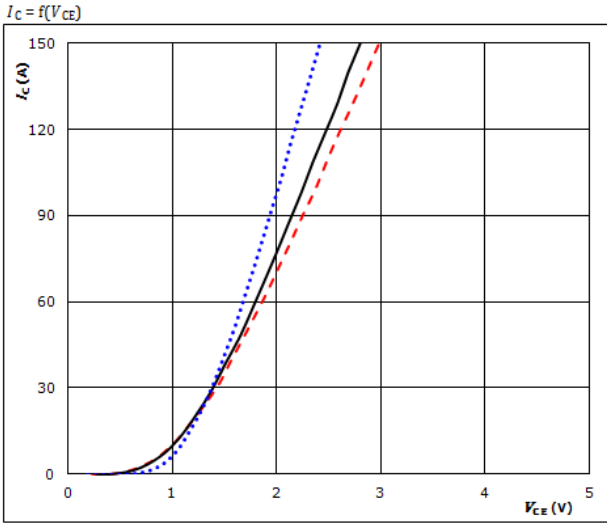
Thermistor

Parameter	Symbol	Conditions					Value			Unit
		V_{CE} [V]	V_{CE} [V]	I_C [A]	T_j [°C]	Min	Typ	Max		
Rated resistance	R				25		21,5		k Ω	
Deviation of R100	$\Delta_{R/R}$	R100=1486 Ω			100	-4,5		+4,5	%	
Power dissipation	P				25		210		mW	
Power dissipation constant					25		3,5		mW/K	
B-value	$B_{(25/50)}$				25		3884		K	
B-value	$B_{(25/100)}$				25		3964		K	
Vincotech NTC Reference								F		



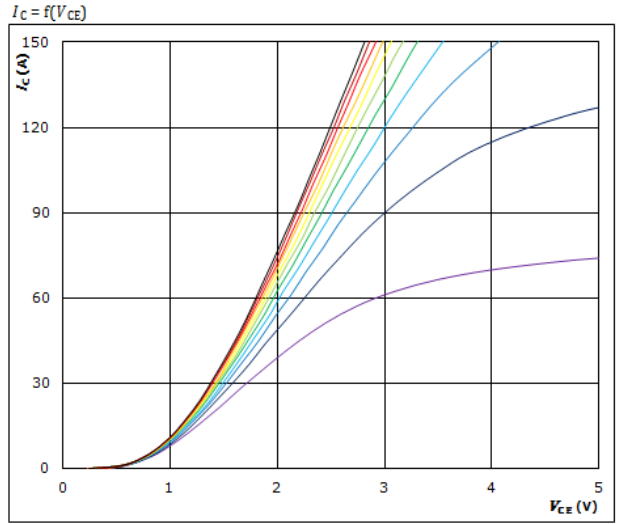
Buck Switch\Out. Boost Switch Characteristics

Typical output characteristics IGBT



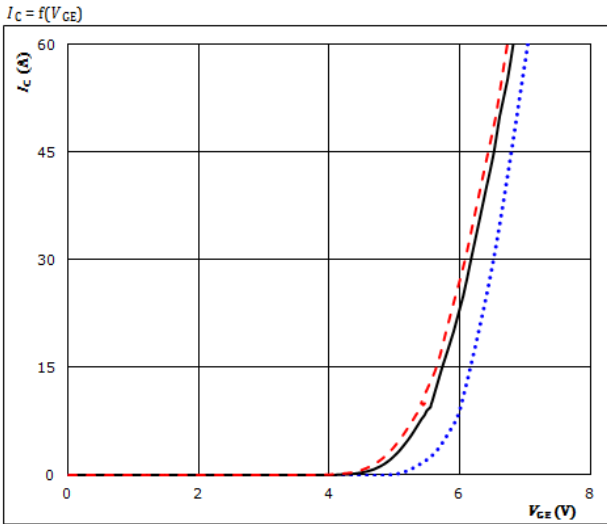
$t_p = 250 \mu s$
 $V_{CE} = 15 V$
25 °C
125 °C ———
150 °C - - - -

Typical output characteristics IGBT



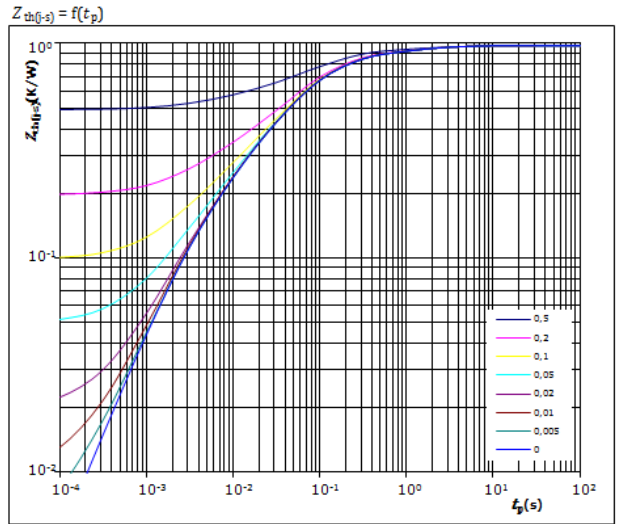
$t_p = 250 \mu s$
 $T_j = 150 \text{ °C}$
 V_{CE} from 7 V to 17 V in steps of 1 V

Typical transfer characteristics IGBT



$t_p = 100 \mu s$
 $V_{CE} = 10 V$
25 °C
125 °C ———
150 °C - - - -

Transient Thermal Impedance as function of Pulse duration IGBT



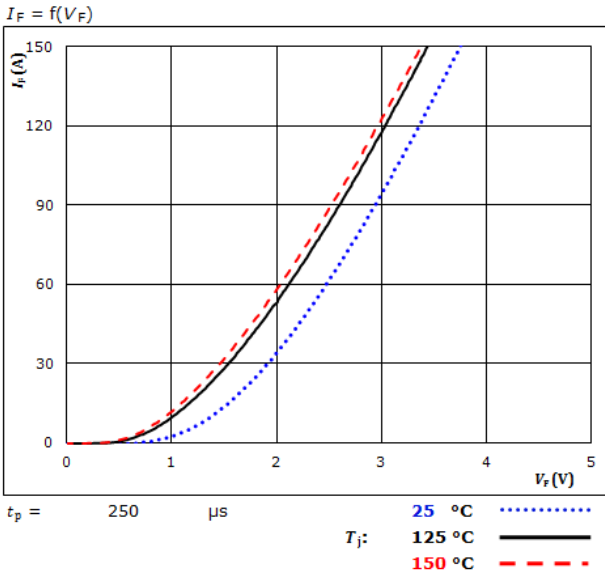
$D = t_p / T$
 $R_{th(j-s)} = 0,98 K/W$
IGBT thermal model values

$R_{th} (K/W)$	$\tau (s)$
9,94E-02	1,63E+00
1,95E-01	2,13E-01
4,61E-01	6,06E-02
1,53E-01	1,16E-02
6,97E-02	2,58E-03

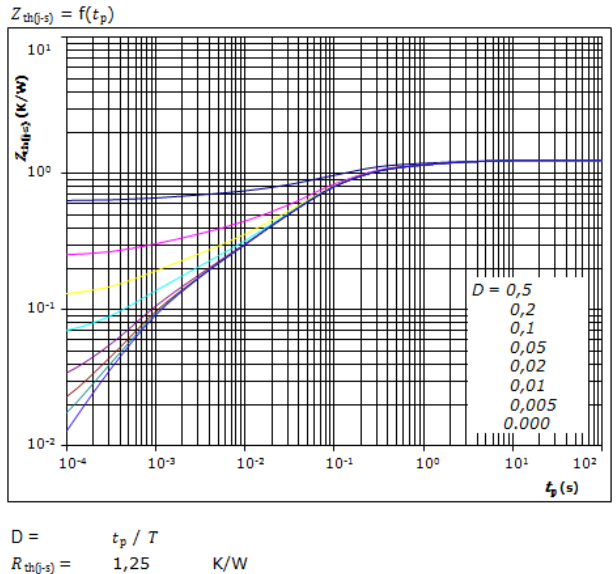


Buck Diode\Out. Boost Diode Characteristics

Typical forward characteristics FWD



Transient thermal impedance as a function of pulse width FWD



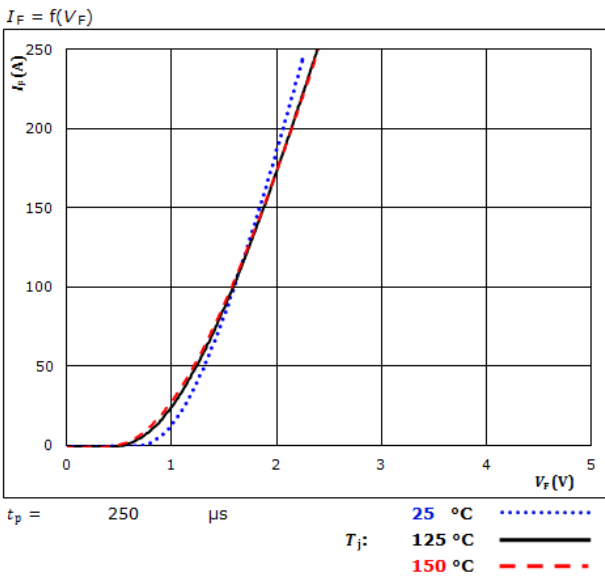
FWD thermal model values

R (K/W)	τ (s)
8,28E-02	3,17E+00
1,76E-01	6,05E-01
5,29E-01	1,07E-01
2,56E-01	3,44E-02
1,19E-01	6,15E-03
8,99E-02	8,86E-04

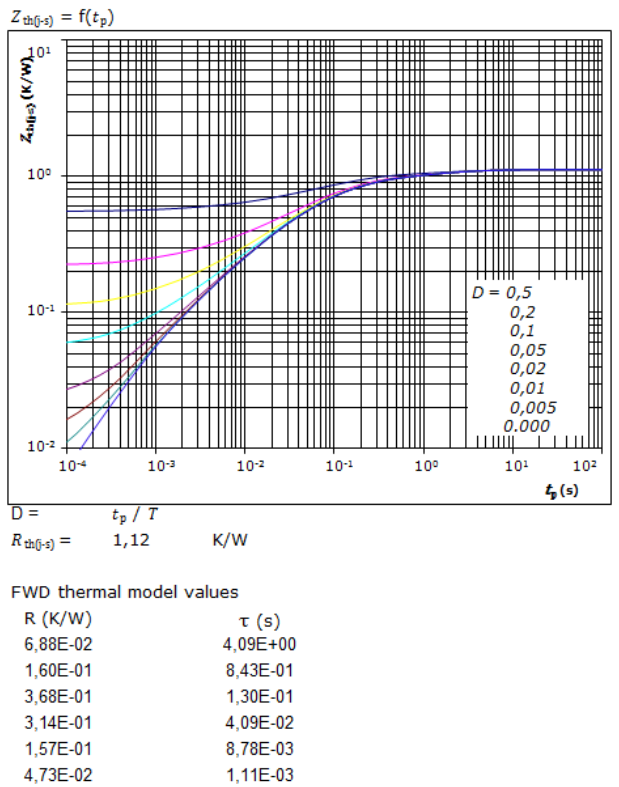


Out. Boost Inv. Diode Characteristics

Typical forward characteristics FWD

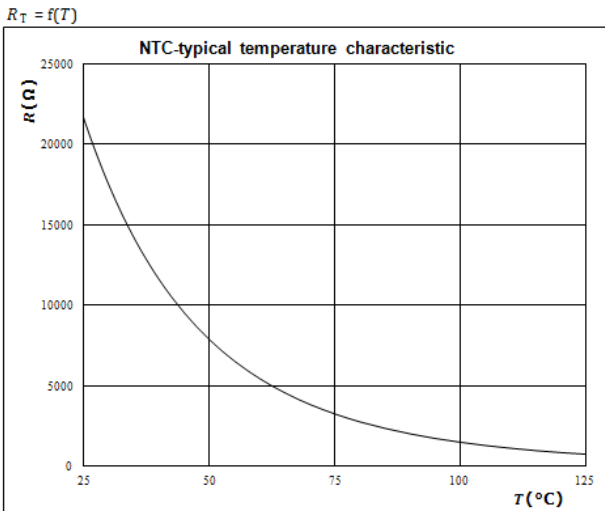


Transient thermal impedance as a function of pulse width FWD



Thermistor Characteristics

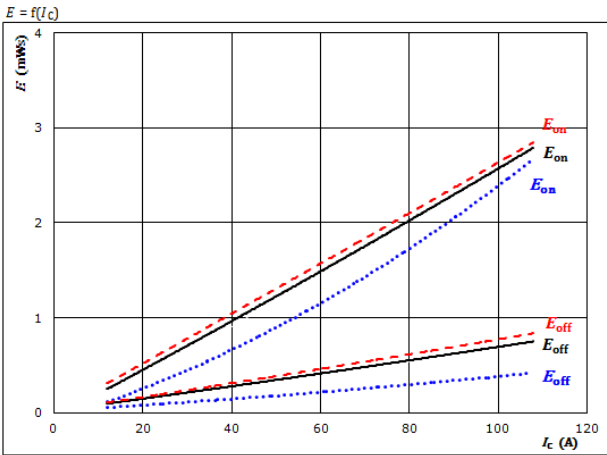
Thermistor typical temperature characteristic
Typical NTC characteristic
as a function of temperature





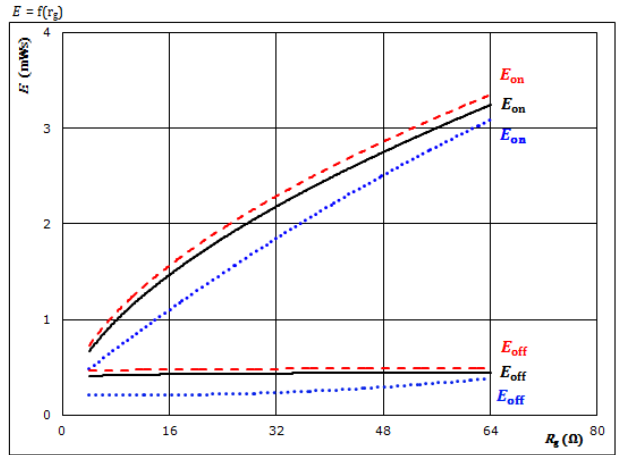
Buck Switching Characteristics

Figure 1. IGBT
Typical switching energy losses as a function of collector current



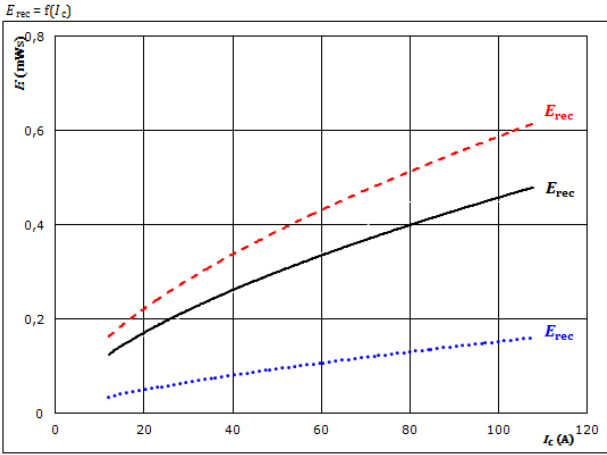
With an inductive load at
 $V_{CE} = 350$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 16$ Ω
 $R_{goff} = 16$ Ω
 T_j : 25 °C
 125 °C ———
 150 °C - - - -

Figure 2. IGBT
Typical switching energy losses as a function of gate resistor



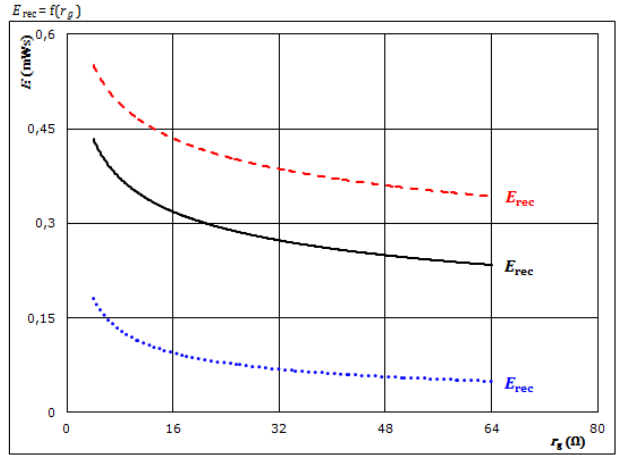
With an inductive load at
 $V_{CE} = 350$ V
 $V_{GE} = \pm 15$ V
 $I_C = 60$ A
 T_j : 25 °C
 125 °C ———
 150 °C - - - -

Figure 3. FWD
Typical reverse recovered energy loss as a function of collector current



With an inductive load at
 $V_{CE} = 350$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 16$ Ω
 T_j : 25 °C
 125 °C ———
 150 °C - - - -

Figure 4. FWD
Typical reverse recovered energy loss as a function of gate resistor



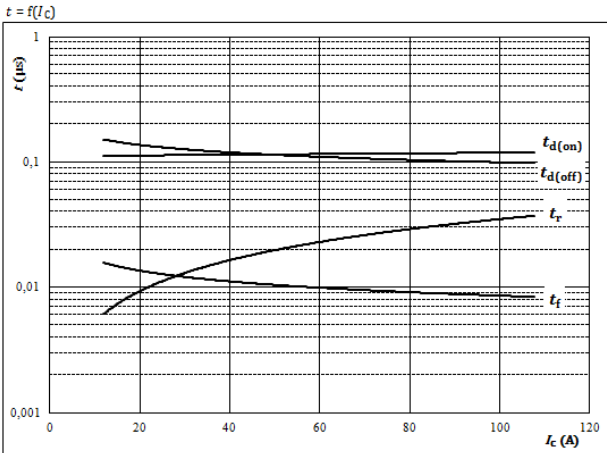
With an inductive load at
 $V_{CE} = 350$ V
 $V_{GE} = \pm 15$ V
 $I_C = 60$ A
 T_j : 25 °C
 125 °C ———
 150 °C - - - -



Buck Switching Characteristics

Figure 5. IGBT

Typical switching times as a function of collector current

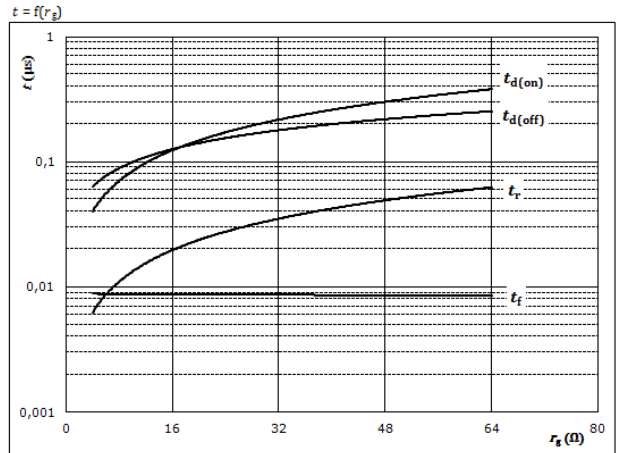


With an inductive load at

$T_j =$	150	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$R_{gon} =$	16	Ω
$R_{goff} =$	16	Ω

Figure 6. IGBT

Typical switching times as a function of gate resistor

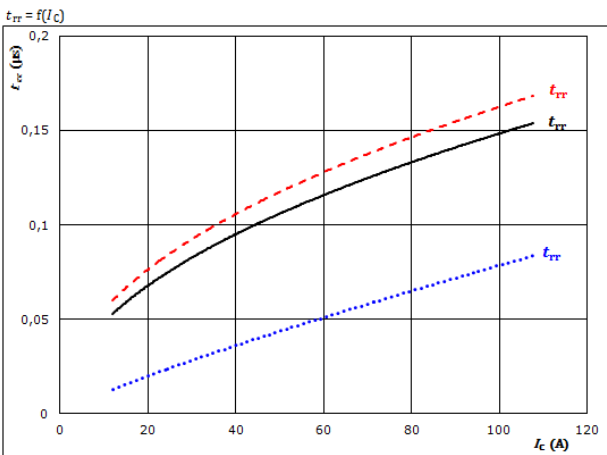


With an inductive load at

$T_j =$	150	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$I_C =$	60	A

Figure 7. FWD

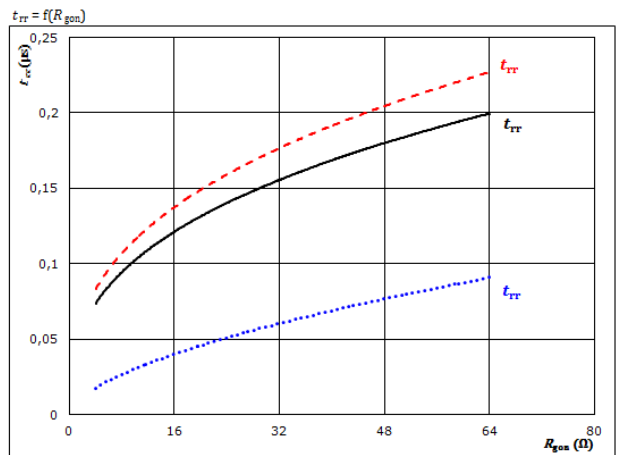
Typical reverse recovery time as a function of collector current



At	$V_{CE} =$	350	V	$T_j:$	25 °C
	$V_{GE} =$	±15	V		125 °C	————
	$R_{gon} =$	16	Ω		150 °C	- - - -

Figure 8. FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor



At	$V_{CE} =$	350	V	$T_j:$	25 °C
	$V_{GE} =$	±15	V		125 °C	————
	$I_C =$	60	A		150 °C	- - - -



Buck Switching Characteristics

Figure 9. FWD
Typical recovered charge as a function of collector current

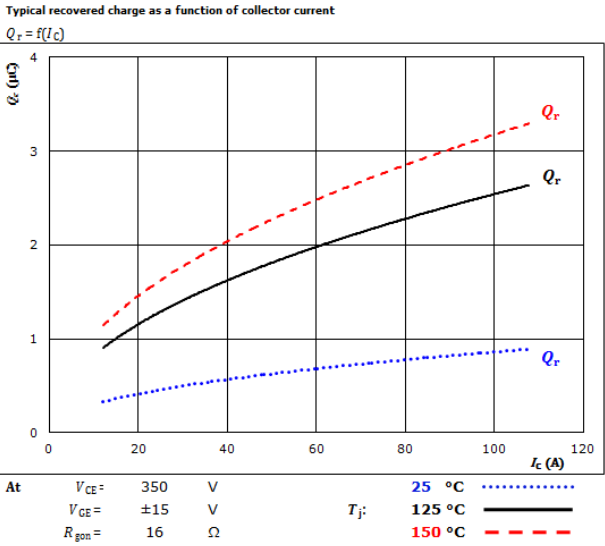


Figure 10. FWD
Typical recovered charge as a function of IGBT turn on gate resistor

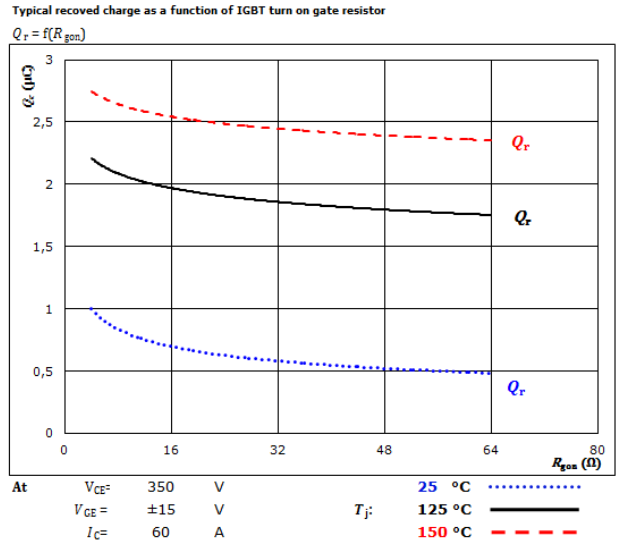


Figure 11. FWD
Typical peak reverse recovery current current as a function of collector current

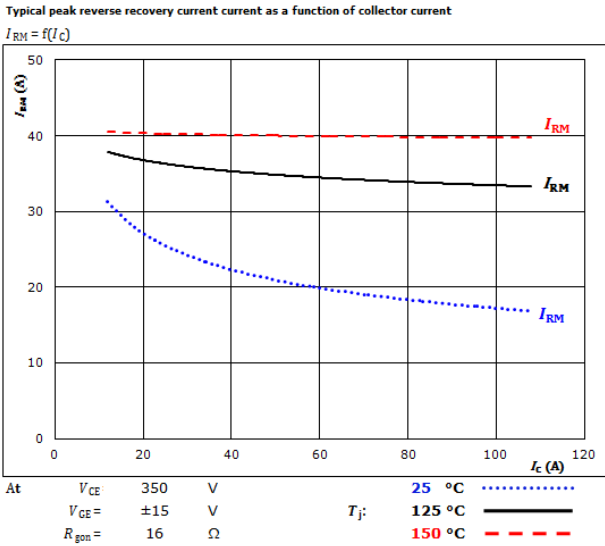
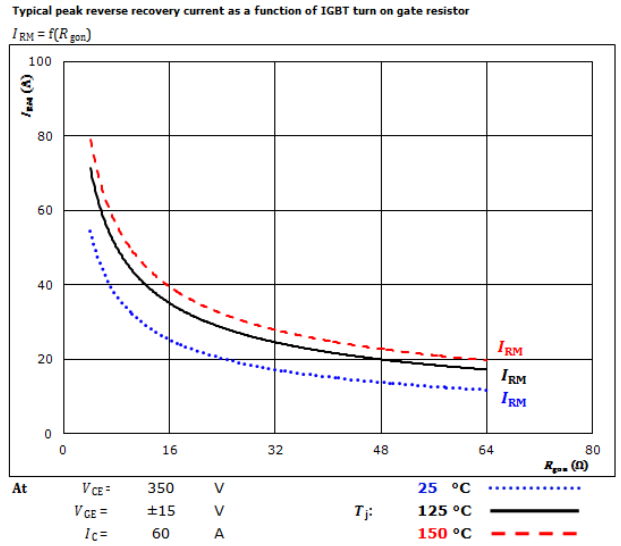


Figure 12. FWD
Typical peak reverse recovery current current as a function of IGBT turn on gate resistor

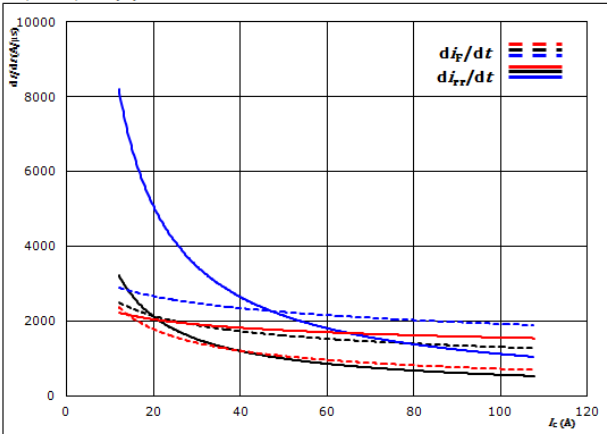




Buck Switching Characteristics

Figure 13. FWD

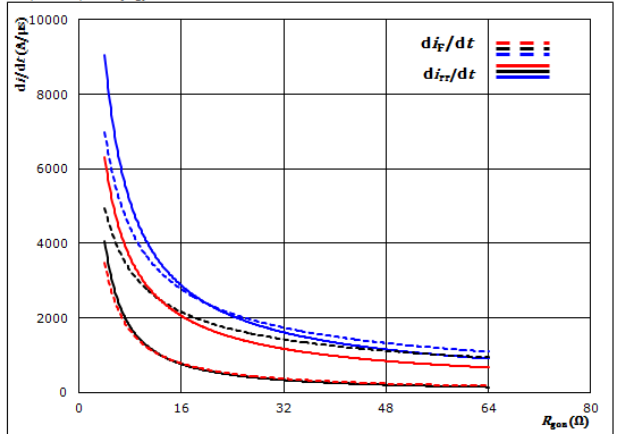
Typical rate of fall of forward and reverse recovery current as a function of collector current
 $di_F/dt, di_{rr}/dt = f(I_C)$



At $V_{CE} = 350$ V
 $V_{CE} = \pm 15$ V
 $R_{gon} = 16$ Ω
 $T_j: 25$ °C
 125 °C
 150 °C

Figure 14. FWD

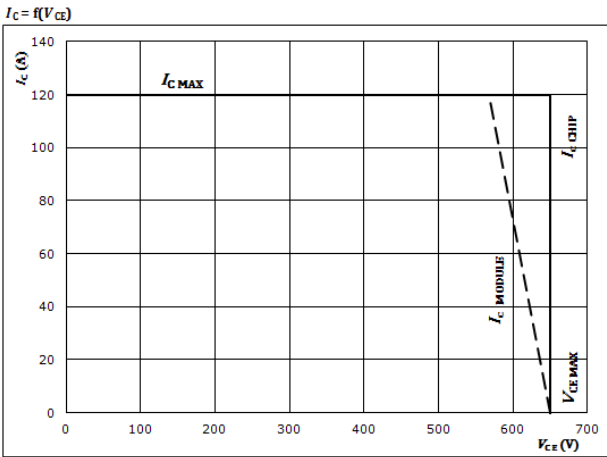
Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor
 $di_F/dt, di_{rr}/dt = f(R_{g})$



At $V_{CE} = 350$ V
 $V_{CE} = \pm 15$ V
 $I_C = 60$ A

Figure 15. IGBT

Reverse bias safe operating area



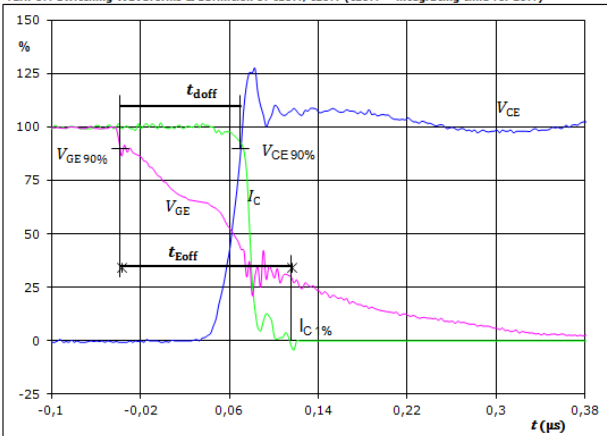
At $T_j = 175$ °C
 $R_{gon} = 16$ Ω
 $R_{goff} = 16$ Ω



Buck Switching Definitions

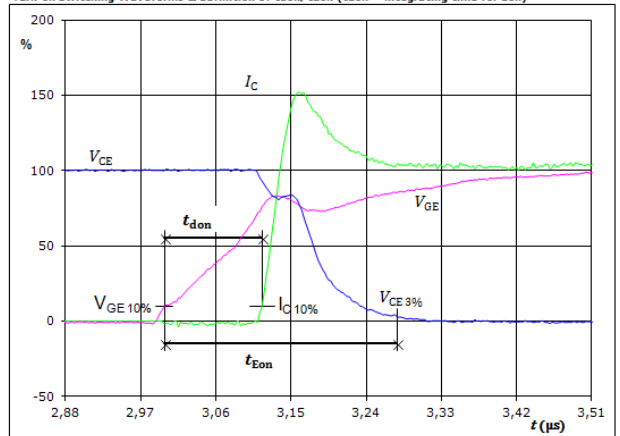
General conditions		
T_j	=	125 °C
R_{gon}	=	16 Ω
R_{goff}	=	16 Ω

Figure 1. IGBT
Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff} (t_{Eoff} = integrating time for E_{off})



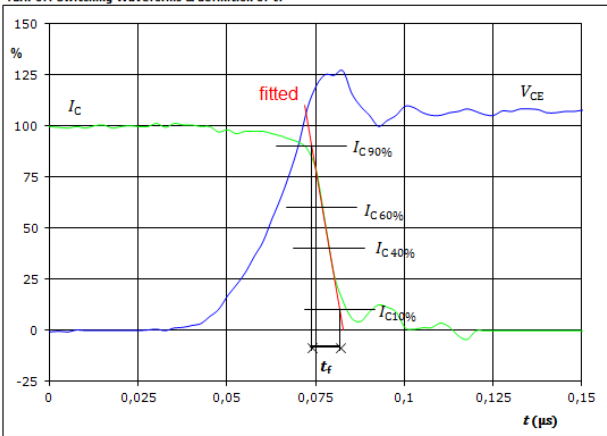
$V_{CE}(0\%) =$	-15	V
$V_{CE}(100\%) =$	15	V
$V_C(100\%) =$	350	V
$I_C(100\%) =$	60	A
$t_{doff} =$	0,108	μs
$t_{Eoff} =$	0,153	μs

Figure 2. IGBT
Turn-on Switching Waveforms & definition of t_{don} , t_{Eon} (t_{Eon} = integrating time for E_{on})



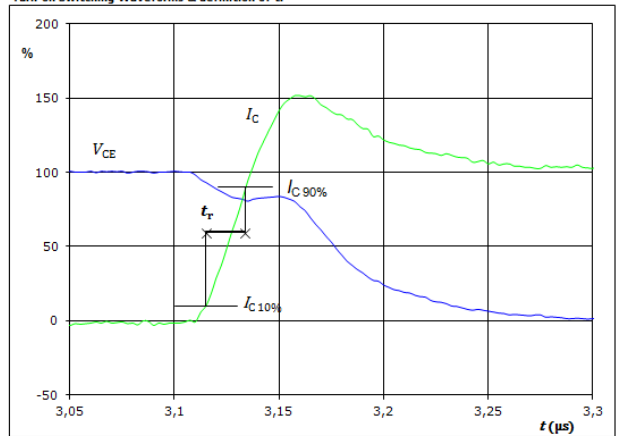
$V_{CE}(0\%) =$	-15	V
$V_{CE}(100\%) =$	15	V
$V_C(100\%) =$	350	V
$I_C(100\%) =$	60	A
$t_{don} =$	0,117	μs
$t_{Eon} =$	0,279	μs

Figure 3. IGBT
Turn-off Switching Waveforms & definition of t_f



$V_C(100\%) =$	350	V
$I_C(100\%) =$	60	A
$t_f =$	0,008	μs

Figure 4. IGBT
Turn-on Switching Waveforms & definition of t_r

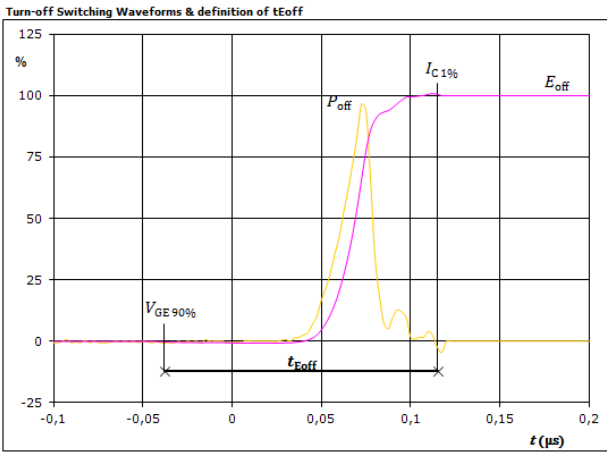


$V_C(100\%) =$	350	V
$I_C(100\%) =$	60	A
$t_r =$	0,019	μs



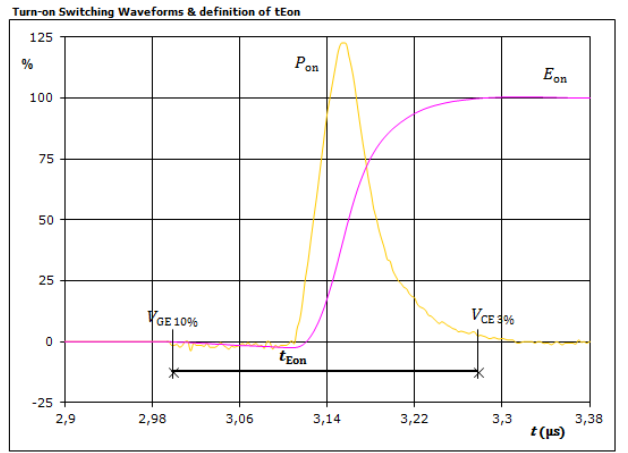
Buck Switching Definitions

Figure 5. IGBT



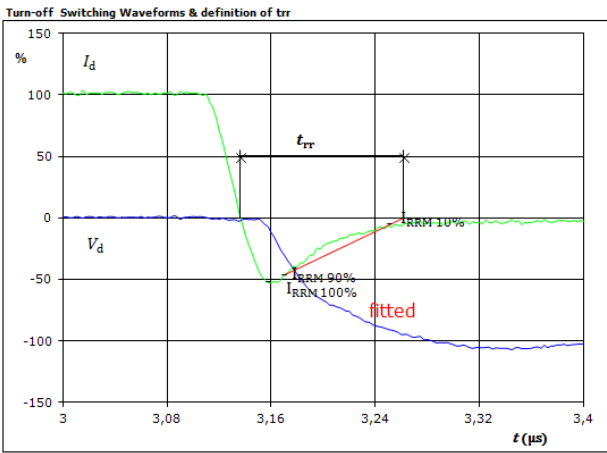
$P_{off}(100\%) =$	20,97	kW
$E_{off}(100\%) =$	0,42	mJ
$t_{Eoff} =$	0,15	μs

Figure 6. IGBT



$P_{on}(100\%) =$	20,97	kW
$E_{on}(100\%) =$	1,49	mJ
$t_{Eon} =$	0,28	μs

Figure 7. FWD



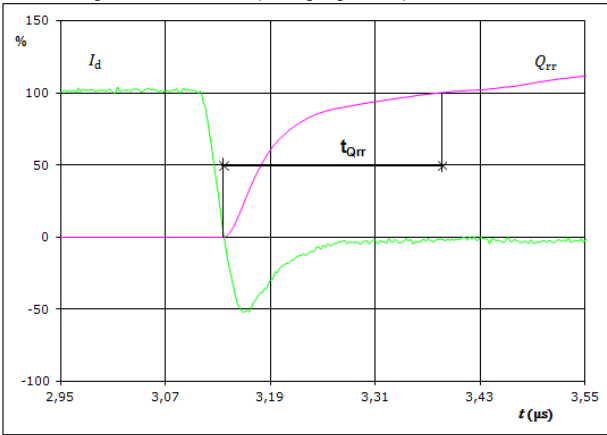
$V_d(100\%) =$	350	V
$I_d(100\%) =$	60	A
$I_{RRM}(100\%) =$	-32	A
$t_{rr} =$	0,124	μs



Buck Switching Definitions

Figure 8. FWD

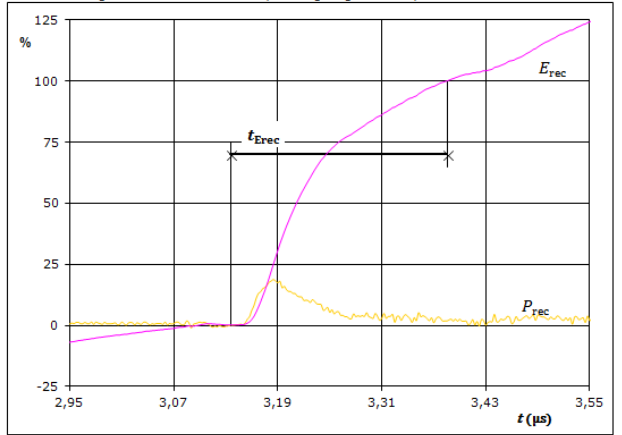
Turn-on Switching Waveforms & definition of t_{Qrr} (t_{Qrr} = integrating time for Q_d)



I_d (100%) =	60	A
Q_{rr} (100%) =	2,07	μC
t_{Qrr} =	0,25	μs

Figure 9. FWD

Turn-on Switching Waveforms & definition of t_{Erec} (t_{Erec} = integrating time for E_{rec})



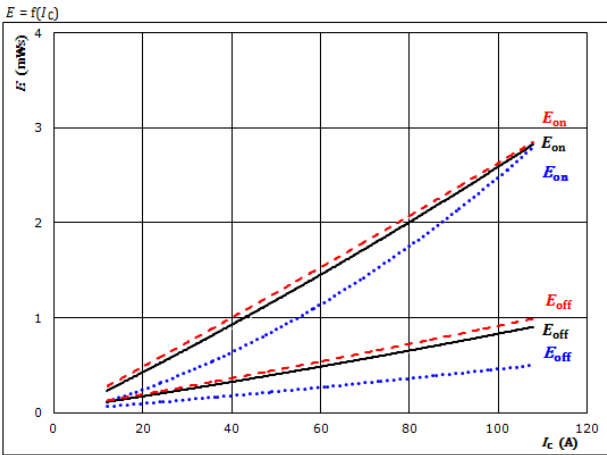
P_{rec} (100%) =	20,97	kW
E_{rec} (100%) =	0,34	mJ
t_{Erec} =	0,25	μs



Out. Boost Switching Characteristics

Figure 1. IGBT

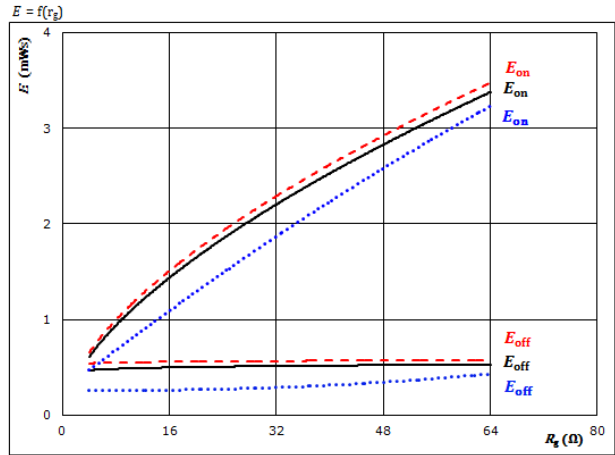
Typical switching energy losses as a function of collector current



With an inductive load at
 $V_{CE} = 350$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 16$ Ω
 $R_{goff} = 16$ Ω
 T_j : 25 °C (dotted), 125 °C (solid), 150 °C (dashed)

Figure 2. IGBT

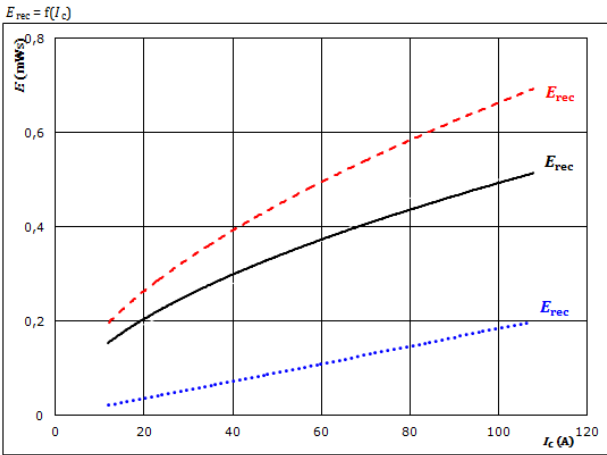
Typical switching energy losses as a function of gate resistor



With an inductive load at
 $V_{CE} = 350$ V
 $V_{GE} = \pm 15$ V
 $I_C = 60$ A
 T_j : 25 °C (dotted), 125 °C (solid), 150 °C (dashed)

Figure 3. FWD

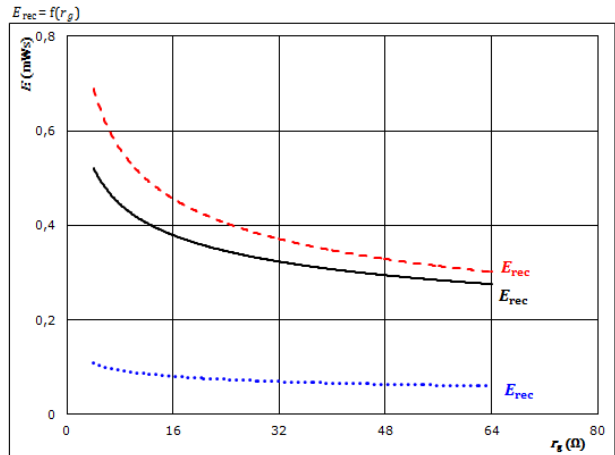
Typical reverse recovered energy loss as a function of collector current



With an inductive load at
 $V_{CE} = 350$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 16$ Ω
 T_j : 25 °C (dotted), 125 °C (solid), 150 °C (dashed)

Figure 4. FWD

Typical reverse recovered energy loss as a function of gate resistor



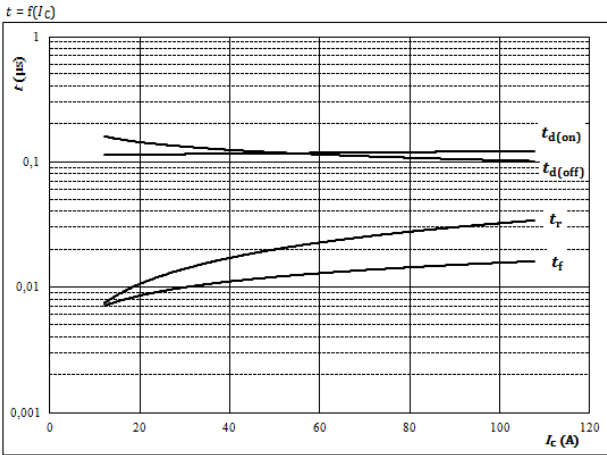
With an inductive load at
 $V_{CE} = 350$ V
 $V_{GE} = \pm 15$ V
 $I_C = 60$ A
 T_j : 25 °C (dotted), 125 °C (solid), 150 °C (dashed)



Out. Boost Switching Characteristics

Figure 5. IGBT

Typical switching times as a function of collector current

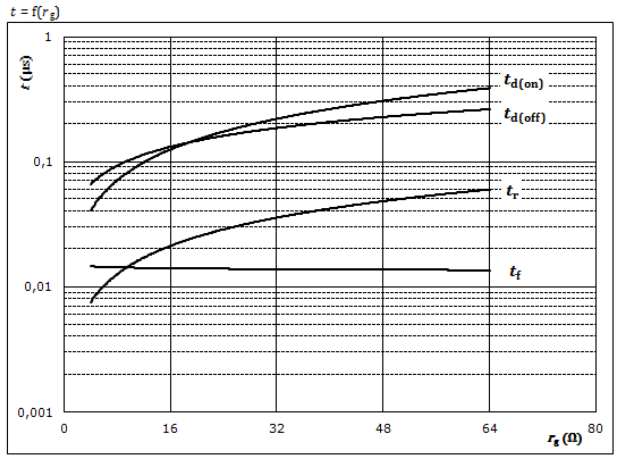


With an inductive load at

$T_j =$	150	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$R_{gon} =$	16	Ω
$R_{goff} =$	16	Ω

Figure 6. IGBT

Typical switching times as a function of gate resistor

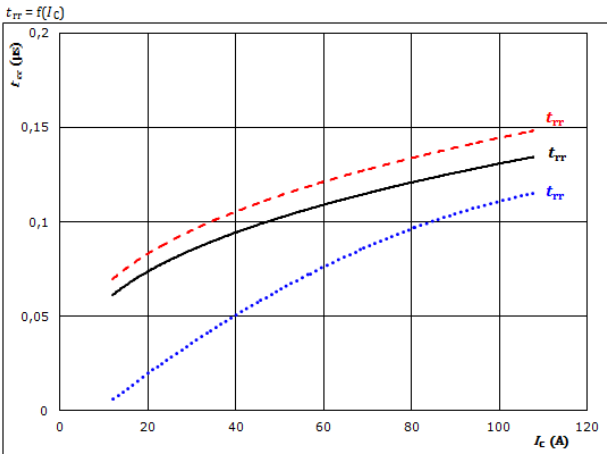


With an inductive load at

$T_j =$	150	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$I_C =$	60	A

Figure 7. FWD

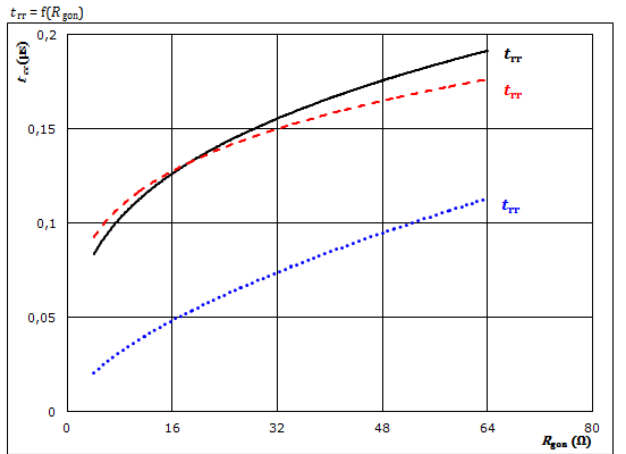
Typical reverse recovery time as a function of collector current



At	$V_{CE} =$	350	V	$T_j:$	25 °C
	$V_{GE} =$	±15	V		125 °C	————
	$R_{gon} =$	16	Ω		150 °C	- - - -

Figure 8. FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor



At	$V_{CE} =$	350	V	$T_j:$	25 °C
	$V_{GE} =$	±15	V		125 °C	————
	$I_C =$	60	A		150 °C	- - - -



Out. Boost Switching Characteristics

Figure 9. FWD
Typical recovered charge as a function of collector current

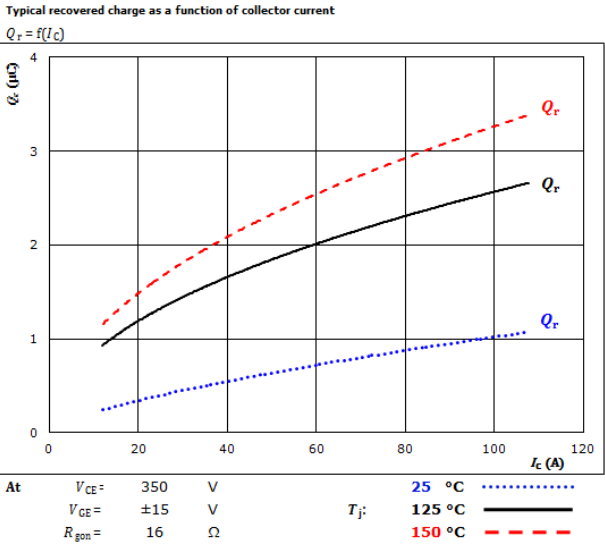


Figure 10. FWD
Typical recovered charge as a function of IGBT turn on gate resistor

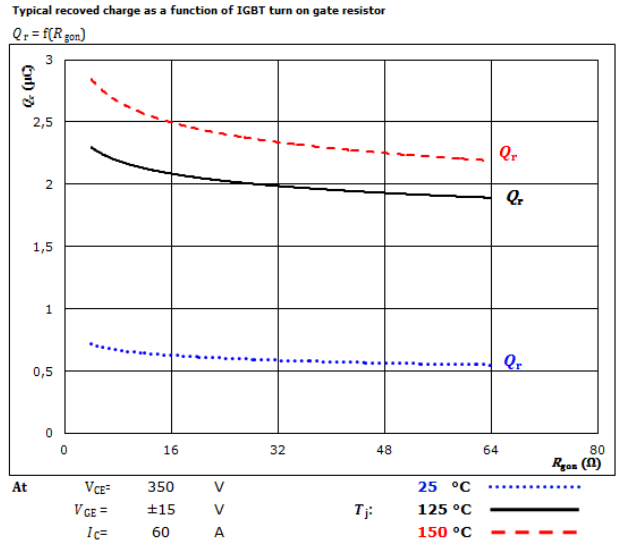


Figure 11. FWD
Typical peak reverse recovery current current as a function of collector current

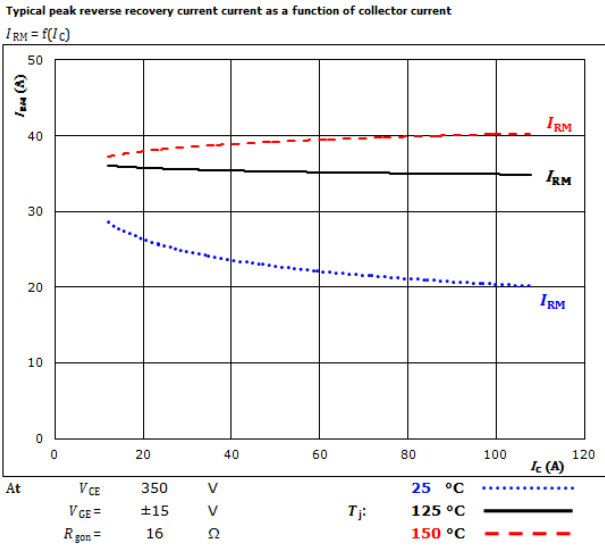
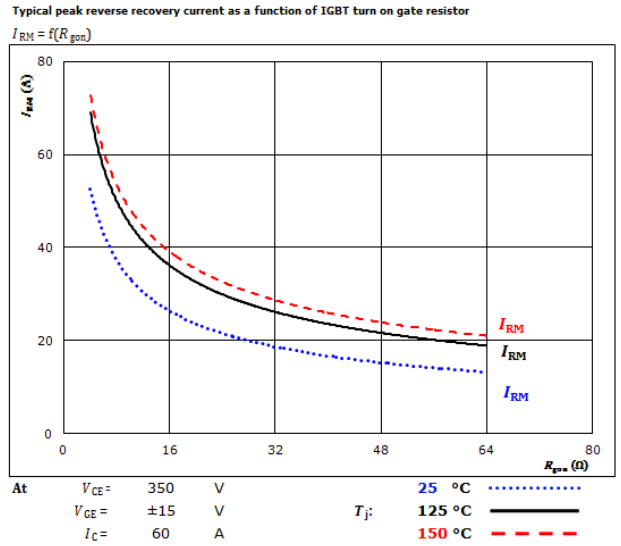


Figure 12. FWD
Typical peak reverse recovery current current as a function of IGBT turn on gate resistor

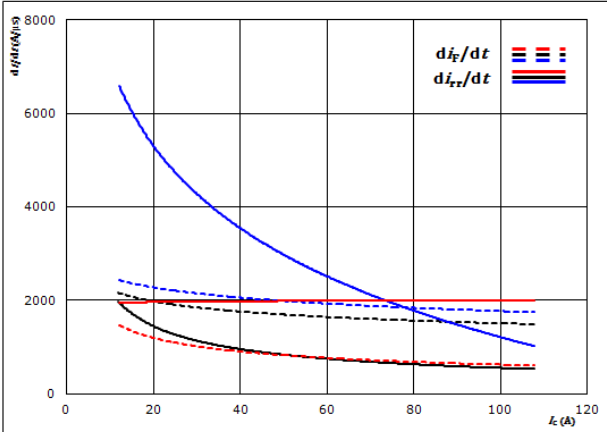




Out. Boost Switching Characteristics

Figure 13. FWD

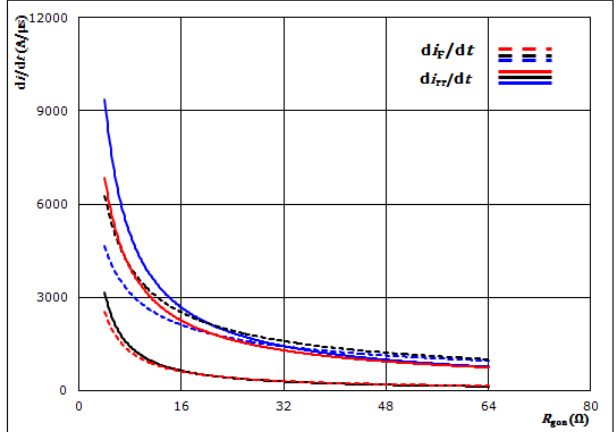
Typical rate of fall of forward and reverse recovery current as a function of collector current
 $di_f/dt, di_{rr}/dt = f(I_c)$



At $V_{CE} = 350$ V
 $V_{CE} = \pm 15$ V
 $R_{gon} = 16$ Ω
 $T_j = 25$ °C
 125 °C
 150 °C

Figure 14. FWD

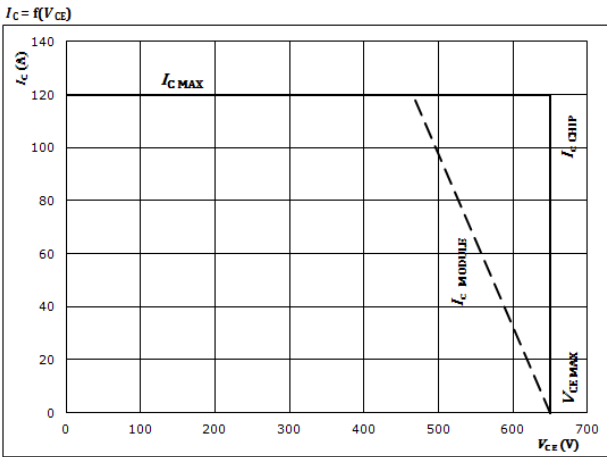
Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor
 $di_f/dt, di_{rr}/dt = f(R_g)$



At $V_{CE} = 350$ V
 $V_{CE} = \pm 15$ V
 $I_c = 60$ A

Figure 15. IGBT

Reverse bias safe operating area



At $T_j = 175$ °C
 $R_{gon} = 16$ Ω
 $R_{goff} = 16$ Ω

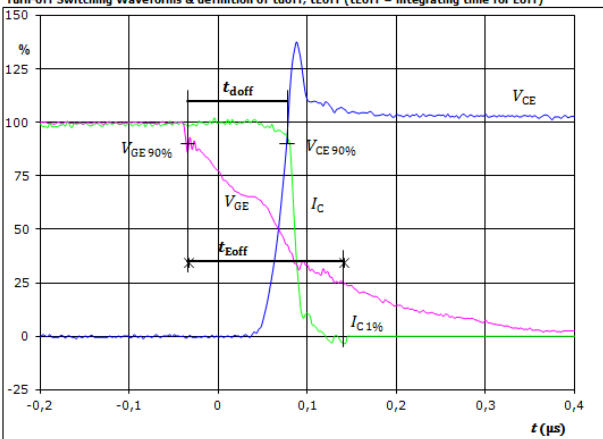


Out. Boost Switching Definitions

General conditions

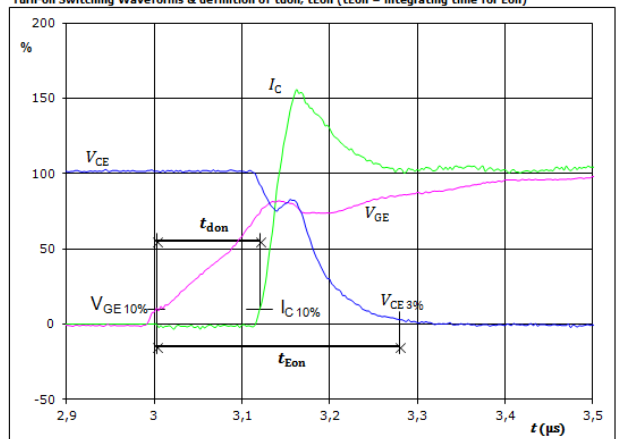
T_j	=	125 °C
R_{gon}	=	16 Ω
R_{goff}	=	16 Ω

Figure 1. IGBT Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff} (t_{Eoff} = integrating time for E_{off})



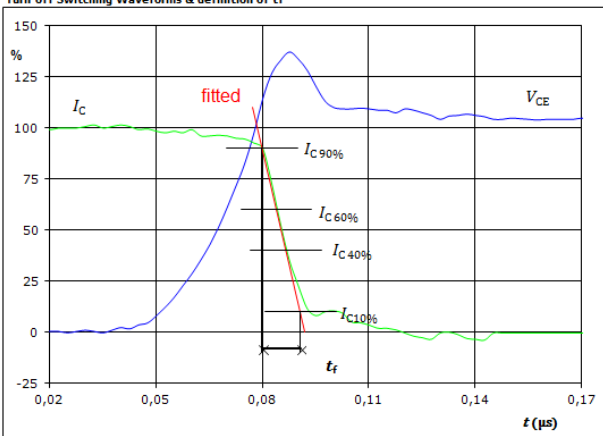
$V_{CE}(0\%) =$	-15	V
$V_{CE}(100\%) =$	15	V
$V_C(100\%) =$	350	V
$I_C(100\%) =$	60	A
$t_{doff} =$	0,112	μs
$t_{Eoff} =$	0,175	μs

Figure 2. IGBT Turn-on Switching Waveforms & definition of t_{don} , t_{Eon} (t_{Eon} = integrating time for E_{on})



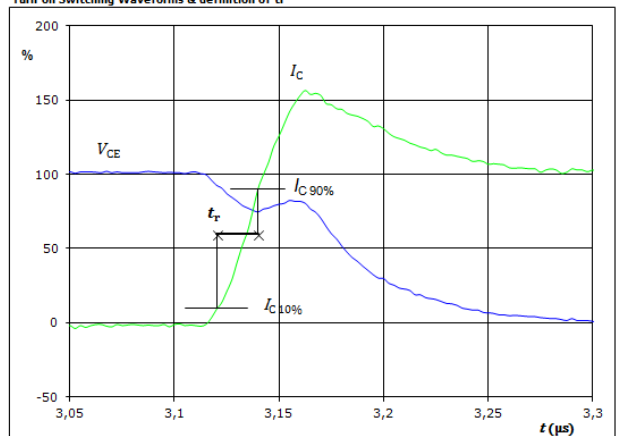
$V_{CE}(0\%) =$	-15	V
$V_{CE}(100\%) =$	15	V
$V_C(100\%) =$	350	V
$I_C(100\%) =$	60	A
$t_{don} =$	0,118	μs
$t_{Eon} =$	0,277	μs

Figure 3. IGBT Turn-off Switching Waveforms & definition of t_f



$V_C(100\%) =$	350	V
$I_C(100\%) =$	60	A
$t_f =$	0,011	μs

Figure 4. IGBT Turn-on Switching Waveforms & definition of t_r

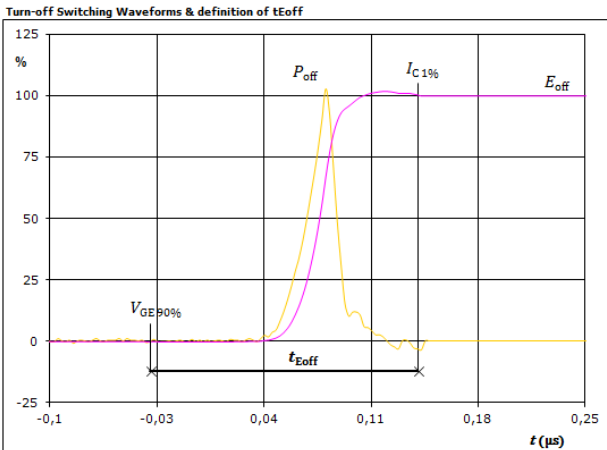


$V_C(100\%) =$	350	V
$I_C(100\%) =$	60	A
$t_r =$	0,02	μs



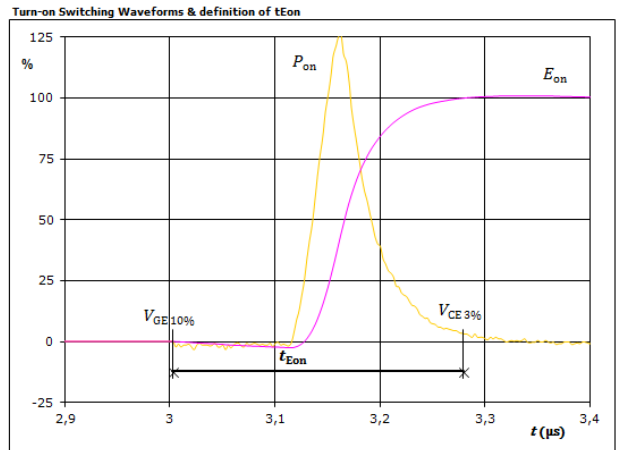
Out. Boost Switching Definitions

Figure 5. IGBT



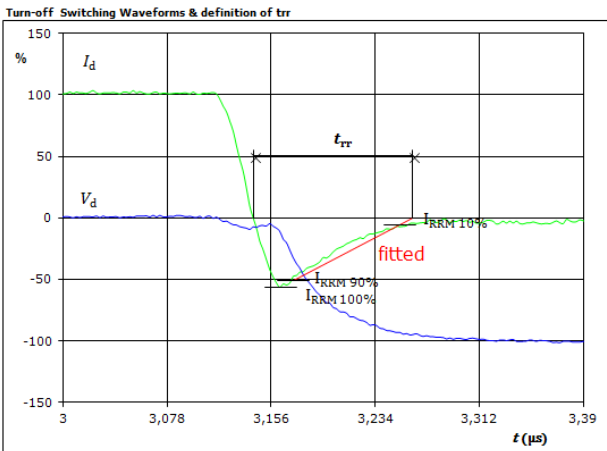
$P_{off}(100\%) =$	20,98	kW
$E_{off}(100\%) =$	0,49	mJ
$t_{Eoff} =$	0,175	μs

Figure 6. IGBT



$P_{on}(100\%) =$	20,98	kW
$E_{on}(100\%) =$	1,45	mJ
$t_{Eon} =$	0,277	μs

Figure 7. FWD

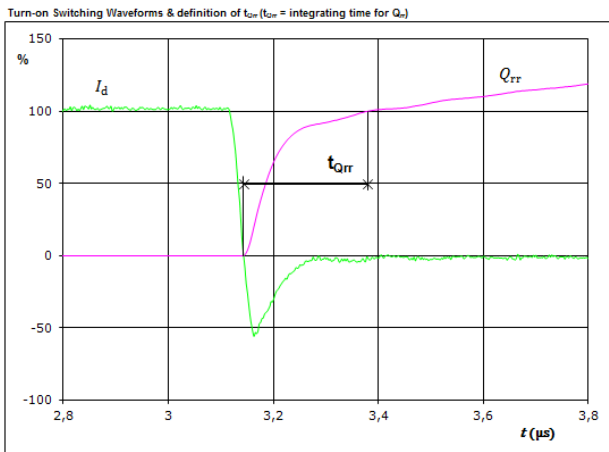


$V_d(100\%) =$	350	V
$I_d(100\%) =$	60	A
$I_{RRM}(100\%) =$	-34	A
$t_{rr} =$	0,119	μs



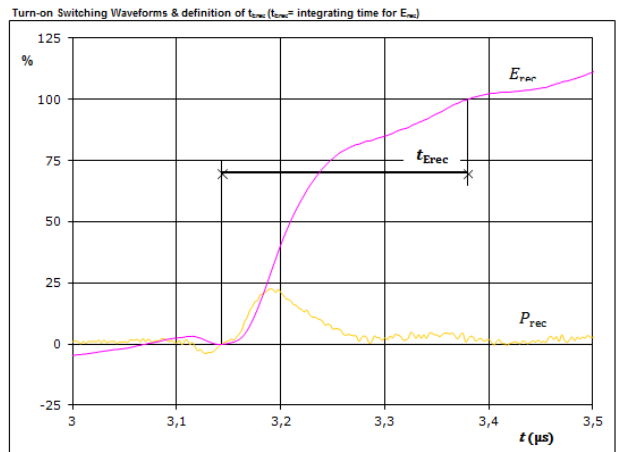
Out. Boost Switching Definitions

Figure 8. FWD



I_d (100%) = 60 A
 Q_{rr} (100%) = 2,07 μC
 t_{Qrr} = 0,24 μs

Figure 9. FWD

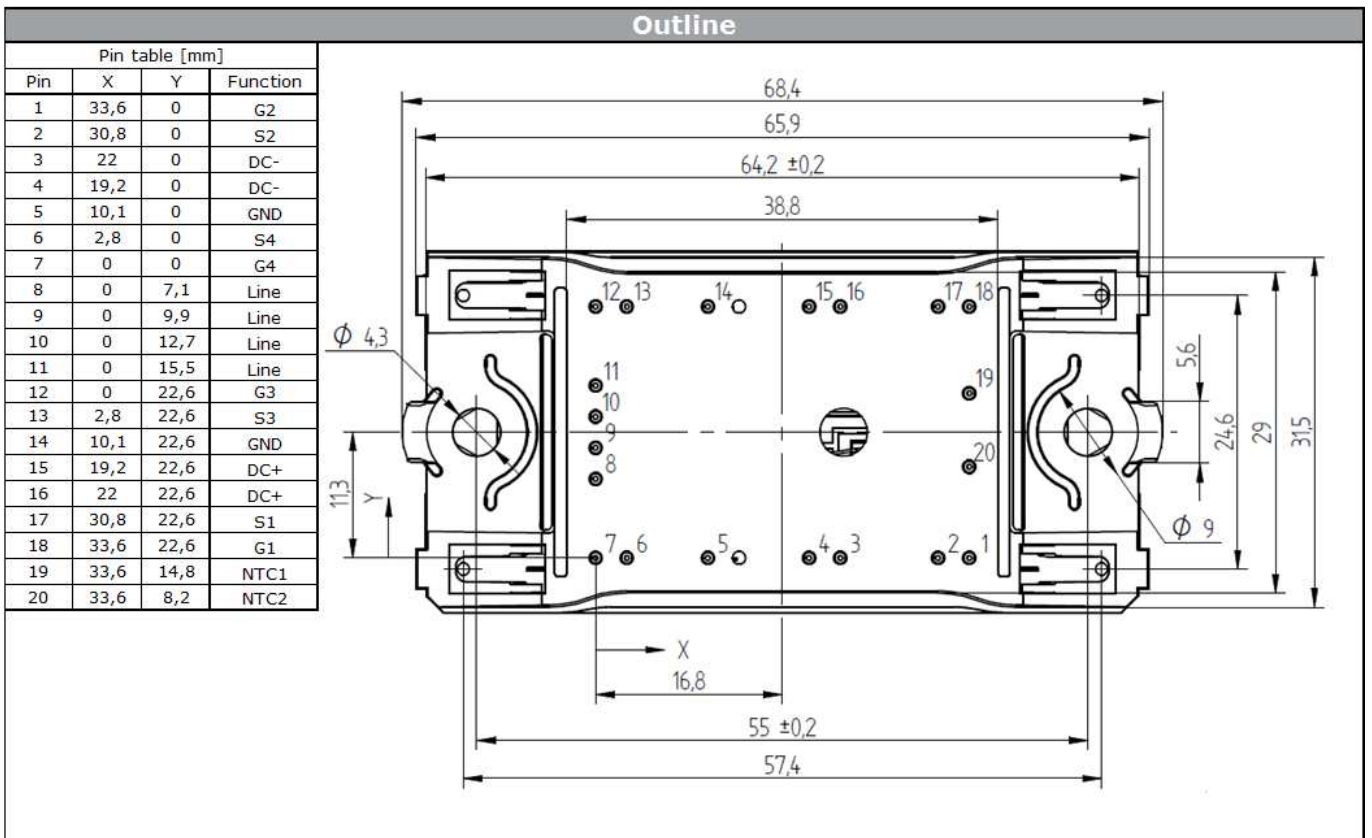


P_{rec} (100%) = 20,98 kW
 E_{rec} (100%) = 0,37 mJ
 t_{Erec} = 0,236 μs



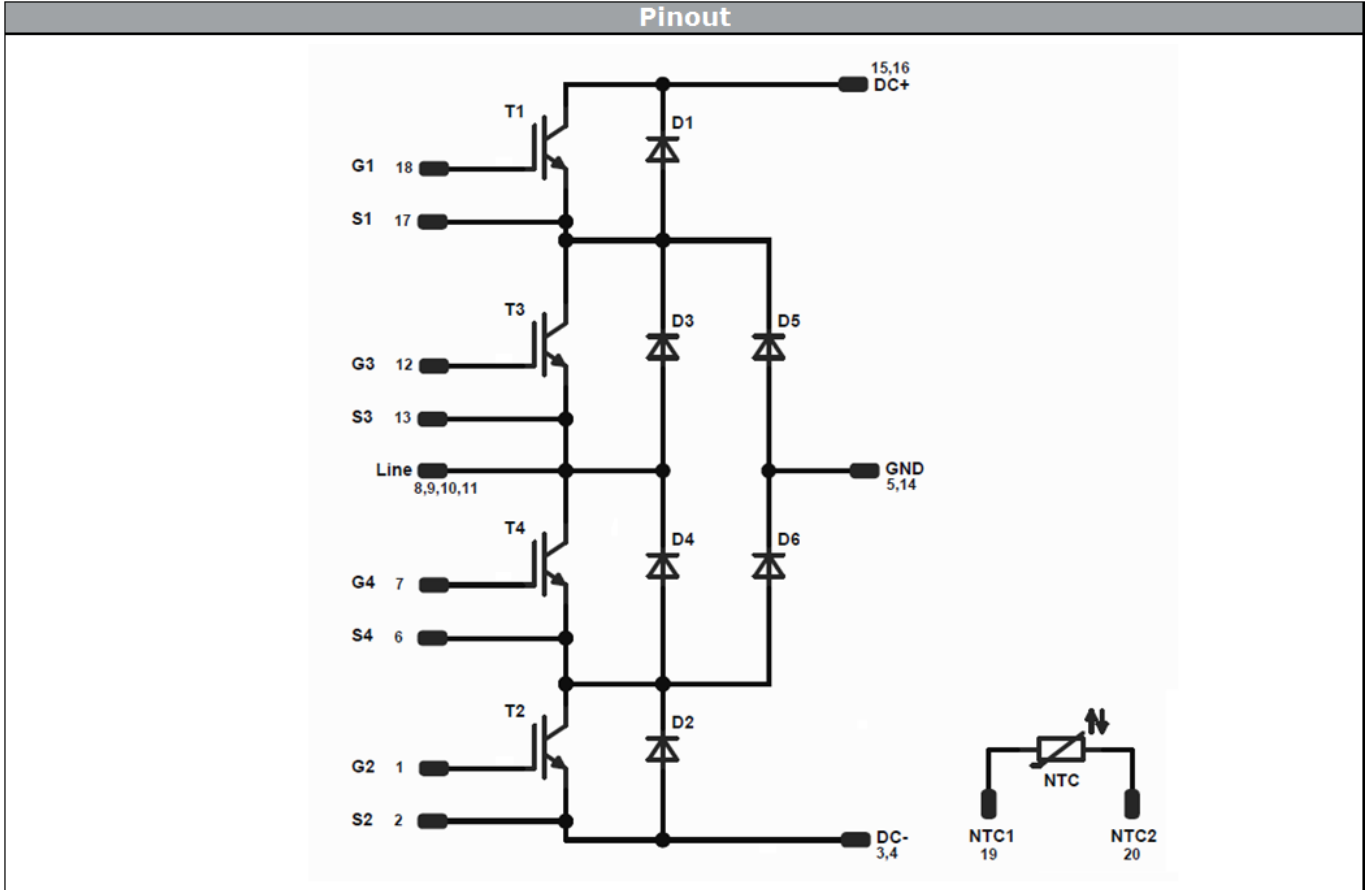
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Ordering Code & Marking							
Version	Ordering Code	in DataMatrix as	in packaging barcode as				
without thermal paste 12 mm housing	10-FZ07NIA060SM-P926F43	P926F43	P926F43				
NN-NNNNNNNNNNNNNN NNNNNNNN WWYY UL Vinco LLLL SSSS		Text	Name	Date code	UL & Vinco	Lot	Serial
		Datamatrix	Type	Lot number	Serial	Date code	
		TTTT-TTT	LLLLL	SSSS	WWYY		





Vincotech



Identification					
ID	Component	Voltage	Current	Function	Comment
T1,T2	IGBT	650V	2x30A	Buck Switch	
D5,D6	FWD	650V	50A	Buck Diode	
T3,T4	IGBT	650V	2x30A	Out. Boost Switch	
D1,D2	FWD	650V	50A	Out. Boost Diode	
D3,D4	FWD	650V	75A	Out. Boost Inv. Diode	
NTC	NTC	-	-	Thermistor	



Vincotech

Packaging instruction					
Standard packaging quantity (SPQ)	135	>SPQ	Standard	<SPQ	Sample

Handling instruction	
Handling instructions for <i>flow</i> 0 packages see vincotech.com website.	

Document No.:	Date:	Modification:	Pages
10-FZ07NIA060SM-P926F43-D1-14	13 Apr. 2015		

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.